

**Notice of References Cited**

Application/Control No.

10/560,723

Applicant(s)/Patent Under  
Reexamination  
EINSTEIN ET AL.

Examiner

SEAN E. AEDER

Art Unit

1642

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0014801 A1	01-2007	Gish et al.	424/155.1
*	B	US-6,812,339	11-2004	Venter et al.	536/24.31
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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